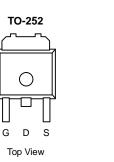
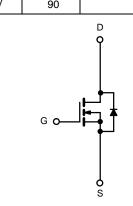


N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^{a, e}	Q _g (Typ)			
30	0.002 at V _{GS} = 10 V	100	72 nC			
30	0.003 at V _{GS} = 4.5 V	90	72110			





N-Channel MOSFET

FEATURES

- TrenchFET[®] Power MOSFET
- 100 % R_g and UIS Tested
 Compliant to RoHS Directive 2011/65/EU

APPLICATIONS

- OR-ing
- Server
- DC/DC

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	30	V		
Gate-Source Voltage		V _{GS}		± 20	
	T _C = 25 °C		100 ^{a, e}		
Continuous Drain Current (T _J = 175 °C)	T _C = 70 °C		80 ^e		
Continuous Drain Current $(1_j = 175^{\circ} C)$	T _A = 25 °C	I _D	35.8 ^{b, c}	A	
	T _A = 70 °C		27 ^{b, c}		
Pulsed Drain Current	I	I _{DM}	300		
Avalanche Current Pulse	L = 0.1 mH	I _{AS}	39		
Single Pulse Avalanche Energy	L = 0.1 mm	E _{AS}	94.8	mJ	
Continuous Source-Drain Diode Current	T _C = 25 °C	1	90 ^{a, e}	^	
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	3.13 ^{b, c}	— A	
	T _C = 25 °C		235 ^a		
Maximum Davies Dissis ation	T _C = 70 °C	P _D	165	10/	
Maximum Power Dissipation	T _A = 25 °C	۲D	3.75 ^{b, c}	W	
	T _A = 70 °C		2.63 ^{b, c}		
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 175	°C		

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Тур.	Max.	Unit		
Maximum Junction-to-Ambient ^{b, d}	$t \le 10 \text{ sec}$	R _{thJA}	32	40	°C/W		
Maximum Junction-to-Case	Steady State	R _{thJC}	0.5	0.6	C/ W		

Notes:

a. Based on $T_C = 25 \text{ °C}$. b. Surface mounted on 1" x 1" FR4 board.

a. t = 10 sec.
d. Maximum under steady state conditions is 90 °C/W.
e. Calculated based on maximum junction temperature. Package limitation current is 90 A.

SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)								
SPECIFICATIONS $(I_J = 25, 0, 0)$ Parameter		Test Conditions	Min.	Typ	Max.	Unit		
Static	Symbol	Test conditions	IVIIII.	Тур.	IVIdX.	Unit		
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	30			V		
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$		00	35		•		
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 7.5		mV/°C		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.5	7.0	2.5	V		
Gate-Source Leakage		$V_{DS} = 0 V, V_{GS} = \pm 20 V$	1.5		± 100	nA		
	I _{DSS}	$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			1			
Zero Gate Voltage Drain Current		$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 \text{ °C}$			10	μA		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 V, V_{GS} = 10 V$	90			A		
		V _{GS} = 10 V, I _D = 38.8 A		0.002				
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 37 \text{ A}$				Ω		
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 38.8 A		160		S		
Dynamic ^b				•		•		
Input Capacitance	C _{iss}			5201		pF		
Output Capacitance	C _{oss}	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz		1525				
Reverse Transfer Capacitance	C _{rss}			770				
		V_{DS} = 15 V, V_{GS} = 10 V, I_{D} = 38.8 A		151	227	1		
Total Gate Charge	Qg			71.5	103			
Gate-Source Charge	Q _{gs}	V_{DS} = 15 V, V_{GS} = 4.5 V, I_{D} = 28.8 A		30		nC		
Gate-Drain Charge	Q _{gd}			24				
Gate Resistance	Rg	f = 1 MHz		1.4	2.1	Ω		
Turn-On Delay Time	t _{d(on)}			18	27			
Rise Time	t _r	V_{DD} = 15 V, R_L = 0.625 Ω		11	17			
Turn-Off Delay Time	t _{d(off)}	${\rm I}_{\rm D}{\cong}24$ A, ${\rm V}_{\rm GEN}$ = 10 V, ${\rm R}_{\rm g}$ = 1 Ω		70	105			
Fall Time	t _f			10	15			
Turn-On Delay Time	t _{d(on)}			55	83	ns		
Rise Time	t _r	V_{DD} = 15 V, R_L = 0.67 Ω		180	270	-		
Turn-Off Delay Time	t _{d(off)}	$\rm I_D\cong$ 22.5 A, $\rm V_{GEN}$ = 4.5 V, $\rm R_g$ = 1 Ω		55	83			
Fall Time	t _f			12	18	-		
Drain-Source Body Diode Characteristics								
Continuous Source-Drain Diode Current	ا _S	T _C = 25 °C			120			
Pulse Diode Forward Current ^a	I _{SM}				120	A		
Body Diode Voltage	V _{SD}	I _S = 22 A		0.8	1.2	V		
Body Diode Reverse Recovery Time	t _{rr}			52	78	ns		
Body Diode Reverse Recovery Charge	Q _{rr}	L = 20.4 di/dt = 100.4/m T = 25.90		70.2	105	nC		
Reverse Recovery Fall Time	t _a	I _F = 20 A, di/dt = 100 A/μs, T _J = 25 °C		27				
Reverse Recovery Rise Time	t _b			25		ns		

Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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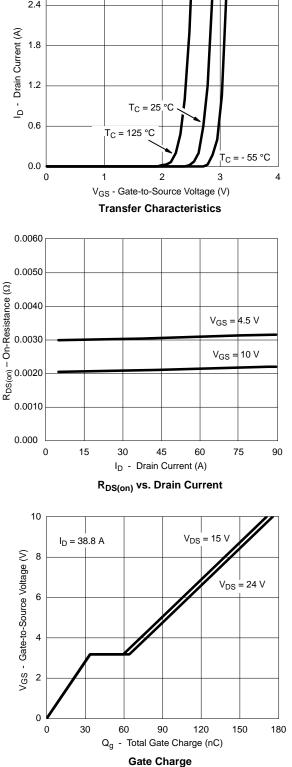
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90



V_{GS} = 10 V thru 4 V 75 2.4 60 I_D - Drain Current (A) I_D - Drain Current (A) 1.8 45 1.2 30 0.6 15 $V_{IGS} = 2 V$ $V_{GS} = 3 V$ 0 0.0 2.0 2.5 0 0.0 0.5 1.0 1.5 V_{DS} - Drain-to-Source Voltage (V) **Output Characteristics** 0.0060 600 T_C = 25 °C 500 0.0050 (C) 0.0030 US (u) 0.0040 OU 0.0020 0.0020 0.0010 G_{fs} - Transconductance (S) T_C = 125 °C 400 300 T_C = - 55 °C 200 100 0.0010 0 0.000 10 20 30 70 80 90 0 0 40 50 60 I_{D} - Drain Current (A) Transconductance 8000 10 Ciss VGS - Gate-to-Source Voltage (V) 6000 8 C - Capacitance (pF) 4000 6 2000 4 Coss 1000 2 Crss 0 0 0 6 12 18 24 30 0 V_{DS} - Drain-to-Source Voltage (V) Capacitance

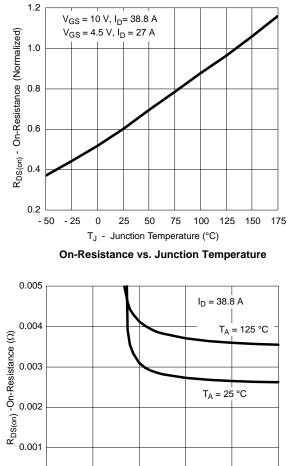
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



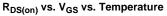
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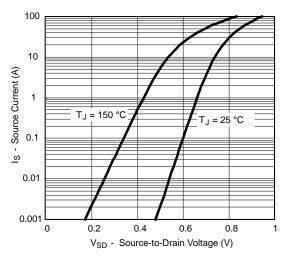


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

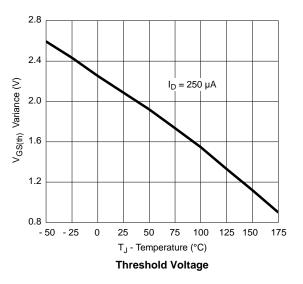


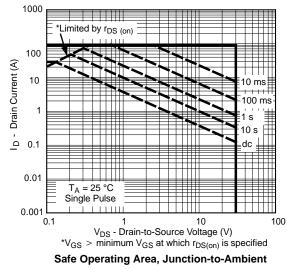
0.000 0 2 4 6 8 V_{GS} - Gate-to-Source Voltage (V)





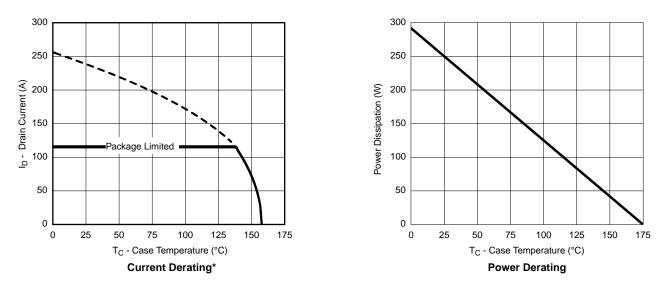
Forward Diode Voltage vs. Temperature





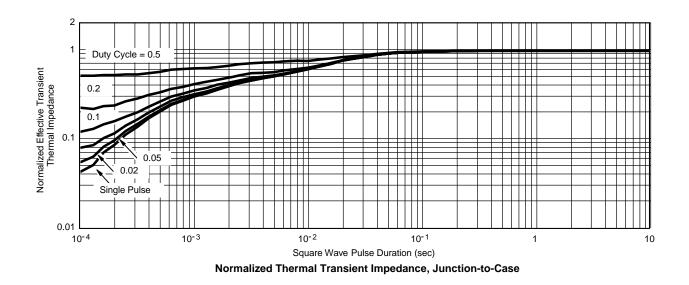
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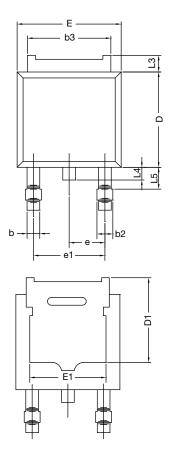
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

*The power dissipation P_D is based on $T_{J(max)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





TO-252AA CASE OUTLINE





	MILLIN	IETERS	INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
А	2.18	2.38	0.086	0.094	
A1	-	0.127	-	0.005	
b	0.64	0.88	0.025	0.035	
b2	0.76	1.14	0.030	0.045	
b3	4.95	5.46	0.195	0.215	
С	0.46	0.61	0.018	0.024	
C2	0.46	0.89	0.018	0.035	
D	5.97	6.22	0.235	0.245	
D1	5.21	-	0.205	-	
E	6.35	6.73	0.250	0.265	
E1	4.32	-	0.170	-	
Н	9.40	10.41	0.370	0.410	
е	2.28	BSC	0.090	BSC	
e1	4.56	BSC	0.180	BSC	
L	1.40	1.78	0.055	0.070	
L3	0.89	1.27	0.035	0.050	
L4	-	1.02	-	0.040	
L5	1.14	1.52	0.045	0.060	
ECN: X12-0247-Rev. M, 24-Dec-12 DWG: 5347					

Note

• Dimension L3 is for reference only.



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